Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination MODER ET AL.	
10/615,337		
Examiner	Art Unit	
Namitha Pillai	2173	

SEARCHED					
Class	Subclass	Date	Examiner		
715	756	4/13/2005	DE		
715	751	5/17/2005	N/E		
715	723	4/15/2005			
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715	754	5/18/2005	M		
715	756	5/18/2005	B		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Databases used: USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	5/17/2005	W.		
See search report for keyword search terms used	5/17/2005	W		
Updated search: Internet	4/29/2006	ALC.		